

SAMSUNG SEMICONDUCTOR INC

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KSC2517

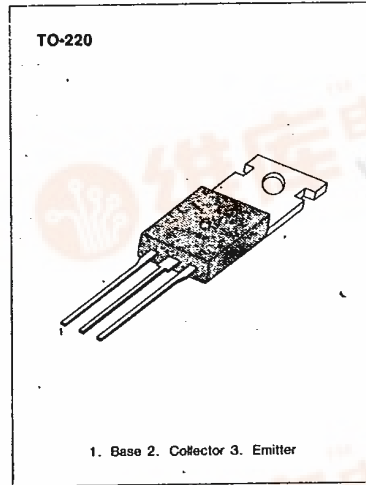
NPN EXITAXIAL SILICON TRANSISTOR

T-33-09

**HIGH SPEED SWITCHING
INDUSTRIAL USE**

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	150	V
Collector-Emitter Voltage	V _{CE0}	100	V
Emitter-Base Voltage	V _{EB0}	12	V
Collector Current (DC)	I _C	5	A
Collector Current (Pulse)	I _C	10	A
Collector Dissipation (T _a = 25°C)	P _C	1.5	W
Collector Dissipation (T _c = 25°C)	P _C	30	W
Base Current	I _B	2.5	A
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



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* PW ≤ 300μs, Duty Cycle < 10%

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Emitter Sustaining Voltage	V _{CE0} (SUS)	I _C = 3A, I _{B1} = 0.3A, L = 1mH	100		V
Collector Emitter Sustaining Voltage	V _{CEx} (SUS)1	I _C = 3A, I _{B1} = -I _{B2} = 0.3A V _{BE} (off) = -5V, L = 180μH Clamped	150		V
Collector Emitter Sustaining Voltage.	V _{CEx} (SUS)2	I _C = 6A, I _{B1} = 1.2A, I _{B2} = -0.3A, V _{BE} (off) = -5V L = 180μA, Clamped	100		V
Collector Cutoff Current	I _{CB0}	V _{CB} = 100V, I _E = 0		10	μA
Collector Cutoff Current	I _{CER}	V _{CE} = 100V; R _{BE} = 51Ω T _a = 125°C		1	mA
Collector Cutoff Current	I _{CEx1}	V _{CE} = 100V, V _{BE} (off) = -1.5V		10	μA
Collector Cutoff Current	I _{CEx2}	V _{CE} = 100V, T _a = 125°C V _{BE} (off) = -1.5V		1	mA
Emitter Cutoff Current	I _{EB0}	V _{EB} = 10V, I _C = 0		10	μA
* DC Current Gain	h _{FE1}	V _{CE} = 5V, I _C = 0.2A	40		
	h _{FE2}	V _{CE} = 5V, I _C = 2A	40	200	
* Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C = 3A, I _B = 0.3A		0.6	V
* Base-Emitter Saturation Voltage	V _{BE} (sat)	I _C = 3A, I _B = 0.3A		1.5	V
Turn On Time	t _{on}	I _C = 3A, R _L = 17Ω, V _{CC} = 50V		0.5	μs
Storage Time	t _s	I _{B1} = -I _{B2} = 0.3A		2.5	μs
Fall Time	t _f			0.5	μs

* Pulse Test: PW ≤ 350μs, Duty Cycle ≤ 2%

h_{FE}(2) CLASSIFICATION

Classification	R	O	Y
h _{FE} (2)	40-80	60-120	100-200

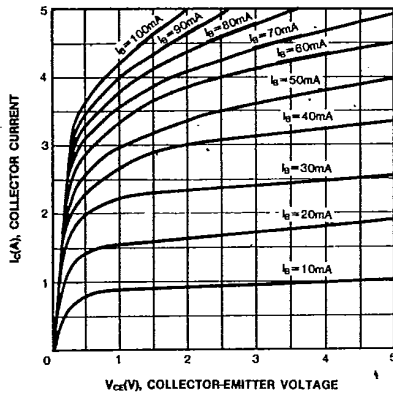


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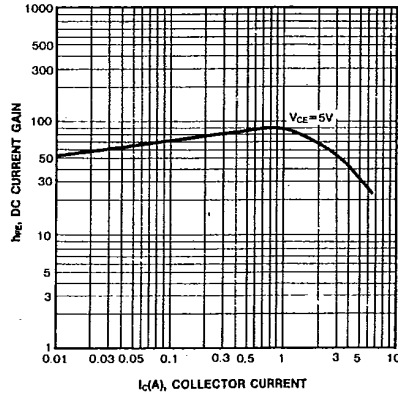
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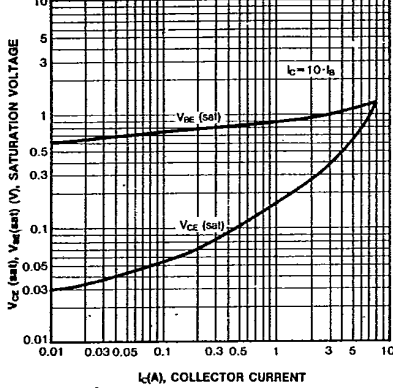
STATIC CHARACTERISTIC



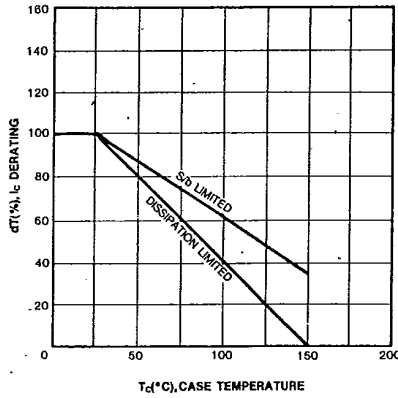
DC CURRENT GAIN



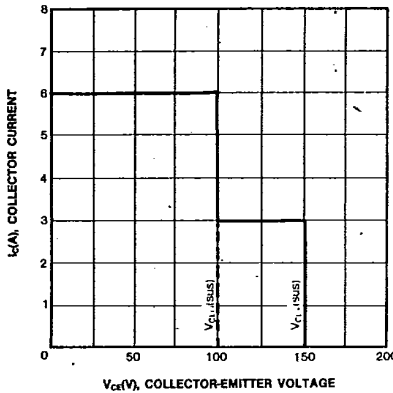
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



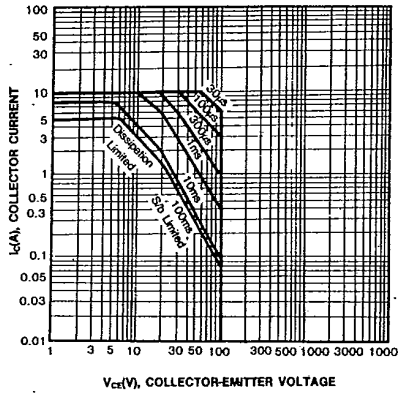
DERATING CURVE OF SAFE OPERATING AREAS



REVERSE BIAS SAFE OPERATING AREAS



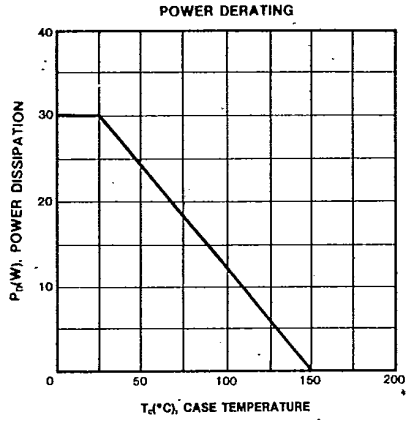
SAFE OPERATING AREA



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KSC2518**NPN EPITAXIAL SILICON TRANSISTOR**

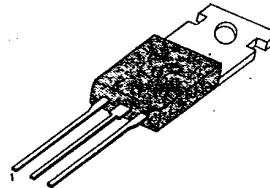
T-33-07

**HIGH SPEED, HIGH VOLTAGE SWITCHING
LOW COLLECTOR SATURATION VOLTAGE
SPECIFIED OF REVERSE BIASED SOA
WITH INDUCTIVE LOADS**

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	500	V
Collector-Emitter Voltage	V_{CEO}	400	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current (DC)	I_C	4	A
* Collector Current (Pulse)	I_C	8	A
Base Current (DC)	I_B	1	A
Collector Dissipation	P_C	15	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-220



1. Base 2. Collector 3. Emitter

* $PW < 350\mu\text{s}$, Duty Cycle $< 10\%$ **ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)**

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Sustaining Voltage	$V_{CE0(sus)}$	$I_C=2A, I_B=0.4A, L=1mH$	400		V
Collector-Emitter Sustaining Voltage	$V_{CEX(sus)1}$	$I_C=2A, I_{B1}=-I_{B2}=0.4A$	450		V
Collector-Emitter Sustaining Voltage	$V_{CEX(sus)2}$	$T_a=125^\circ\text{C}, L=180\mu H, \text{Clamped}$ $I_C=4A, I_{B1}=0.8A, -I_{B2}=0.4A$	400		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=400V, I_E=0$		10	μA
Collector Cutoff Current	I_{CER}	$V_{CE}=400V, R_{BE}=51\Omega, T_a=125^\circ\text{C}$		1	mA
Collector Cutoff Current	I_{CEX1}	$V_{CE}=400V, V_{BE(off)}=-1.5V$		10	μA
Collector Cutoff Current	I_{CEX2}	$V_{CE}=400V, V_{BE(off)}=-1.5V$ $T_a=125^\circ\text{C}$		1	mA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5V, I_C=0$		10	μA
* DC Current Gain	h_{FE1}	$V_{CE}=5V, I_C=0.3A$	20	80	
	h_{FE2}	$V_{CE}=5V, I_C=1.5A$	10		
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=1.5A, I_B=0.3A$		1	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=1.5A, I_B=0.3A$		1.5	V
Turn On Time	t_{on}	$I_C=2A, I_{B1}=-I_{B2}=0.4A$		1	μs
Storage Time	t_{stg}	$R_L=75\Omega, V_{CC}=150V$		2.5	μs
Fall Time	t_f			0.7	μs

* Pulse Test: $PW < 350\mu\text{s}$, Duty Cycle $< 2\%$ Pulsed **h_{FE} (1) CLASSIFICATION**

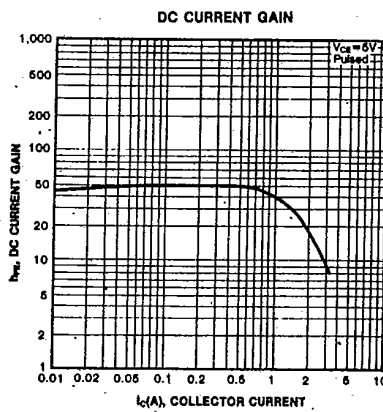
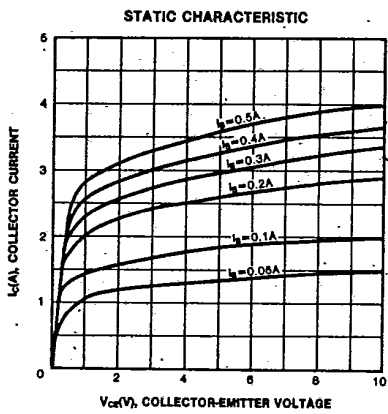
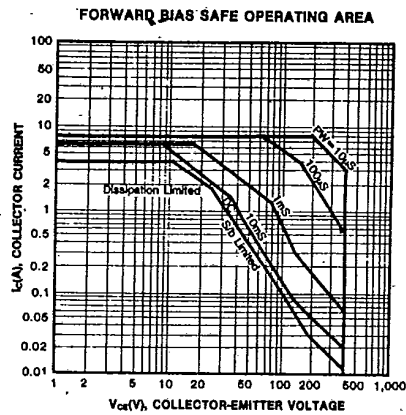
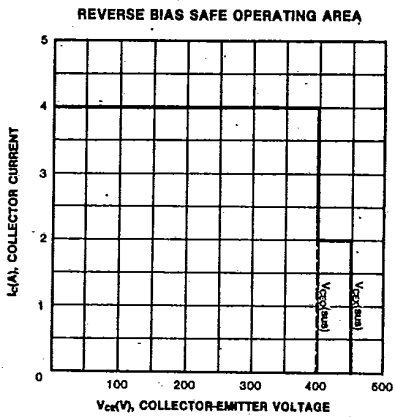
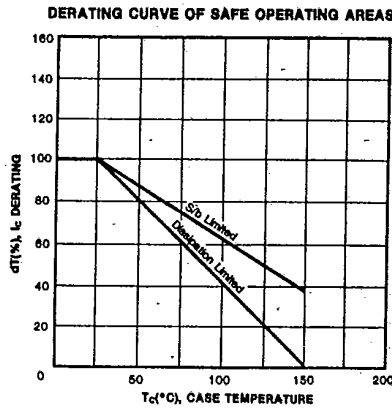
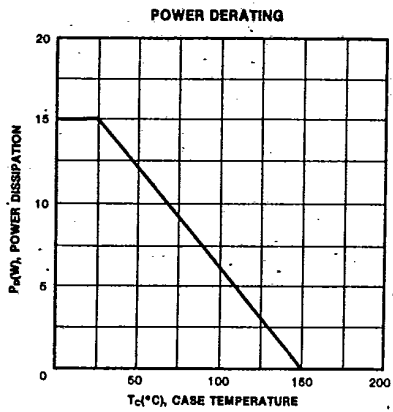
Classification	R	O	Y
h_{FE1}	20-40	30-60	40-80



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